


<b>Search Notes</b>  	<b>Application/Control No.</b>  10520159	<b>Applicant(s)/Patent Under Reexamination</b>  WAKAMATSU, MICHIO
	<b>Examiner</b>  DAVID Q NGUYEN	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
455	445	04/24/09	DN
455	432.1	04/24/09	DN
455	524	04/24/09	DN

SEARCH NOTES		
Search Notes	Date	Examiner
Text search	04/24/09	DN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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